Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/850,114	TAKENAGA, TAKASHI
Examiner	Art Unit
Djenane M. Bayard	2141

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SEARCHED					
Class	Subclass	Date	Examiner		
709	206	8/17/2005	DB		
709	218	8/17/2005	DB		
345	619	8/17/2005	DB		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
709	206	8/17/2005	DB	
709	218	8/17/2005	DB	
345	619	8/17/2005	DB	
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SEARCH NOT (INCLUDING SEARCH S)
	DATE	EXMR
East	8/17/2005	DB
NPL (google, IEEE, safari online book)	8/17/2005	DB
Consulted with M. Meky	8/17/2005	DB
Stic Search (Npl and Patent Literature)	8/8/2005	DB
Inventor's search	8/19/2005	